

**Search Notes**

Application/Control No.

10/822,664

Examiner

John Q. Nguyen

Applicant(s)/Patent under  
Reexamination

KITAMURA ET AL.

Art Unit

3654

**SEARCHED**

Class	Subclass	Date	Examiner
242	348 348.2	6/22/05 ↓	JN ↓
360	132	↓	↓

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR